

N-Channel Enhancement Mode MOSFET

Feature

- 80V/185A $R_{DS(ON)} = 2.8m\Omega \text{ (typ.) } @V_{GS} = 10V$
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen- Free and Green Devices Available (RoHS Compliant)

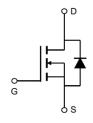
Pin Description



TO-247A-3L

Applications

- Power Switching application
- Uninterruptible Power Supply



N-Channel MOSFET

Ordering and Marking Information



Package Code W:TO-247A-3L

Date Code XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)		•	1
VDSS	Drain-Source Voltage		80	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
Is	Source Current-Continuous(Body Diode)	Tc=25°C	185	А
Mounted on	Large Heat Sink			1
IDM	Pulsed Drain Current *	Tc=25°C	650	А
	Continuous Dunin Comment	Tc=25°C	185	А
lσ	Continuous Drain Current	Tc=100°C	130.8	А
ъ	Mariana Baran Biratantia	Tc=25°C	230.8	W
Pb	Maximum Power Dissipation	Tc=100°C	115.4	W
$R_{\theta C}$	Thermal Resistance-Junction to Case		0.65	°C/W
$R_{ ext{NA}}$	Thermal Resistance-Junction to Ambient **		40	°C/W
Eas	SinglePulsed-Avalanche Energy ***	L=0.3mH	635	mJ

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface Mounted on FR4 Board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.3mH, VD= 64V, VGs =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Comple al	Povemeter.	Toot Conditions	HYG032N08NS1		l lusit	
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	80	-		V
Inco	Drain to Source Leakage Current	VDS=80,VGS=0V	-	-	1	μA
loss Drain-to-Source LeakageCurrent	Diam-to-Source LeakageCurrent	TJ=125°C	-	-	50	μA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	2	3	4	V
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	ı	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =50A		2.8	3.2	mΩ
Diode Characteristics						
VsD*	Diode Forward Voltage	Isp=50A,Vgs=0V	ı	0.88	1.2	V
trr	Reverse Recovery Time	Isp=50A,dIsp/dt=100A/µs	-	64	-	ns
Qrr	Reverse Recovery Charge	- 15D=50A, α15D/αl=100A/μS	-	110	-	nC

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Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

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Symbol	Parameter Test Conditions		Min	Тур.	Max	Unit
Dynamic (Dynamic Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	3.7	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	7500	-	
Coss	Output Capacitance	V _{DS} =25V,	-	2750	-	pF
Crss	Reverse Transfer Capacitance	Frequency=500KHz	-	169	-	
td(ON)	Turn-on Delay Time		-	23	-	
Tr	Turn-on Rise Time	$V_{DD}=40V,R_{G}=4\Omega,$	-	118	-	20
td(OFF)	Turn-off Delay Time	lps=50A,Vgs=10V	-	81	-	ns
Tf	Turn-off Fall Time		-	114	-	
Gate Charge Characteristics						
Qg	Total Gate Charge	V 64V V 10V	-	117	-	
Qgs	Gate-Source Charge	$V_{DS} = 64V, V_{GS} = 10V,$ $I_{D} = 50A$	-	38	-	nC
Qgd	Gate-Drain Charge	ID=30A	-	27	-	

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

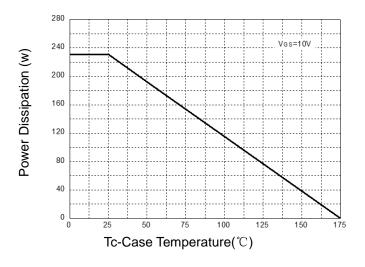


Figure 3: Safe Operation Area

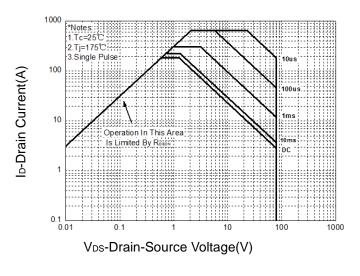


Figure 5: Output Characteristics

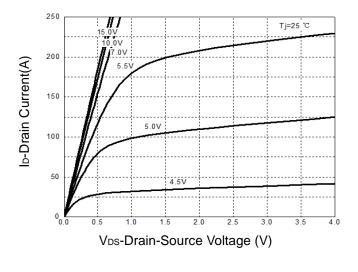


Figure 2: Drain Current

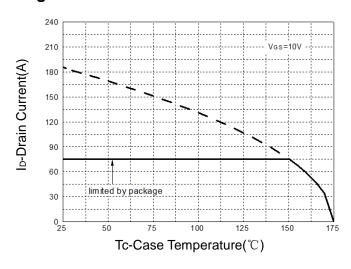


Figure 4: Thermal Transient Impedance

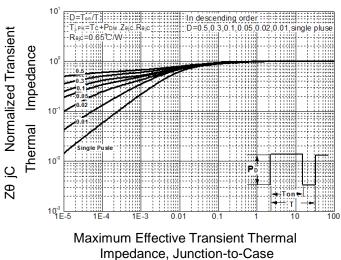
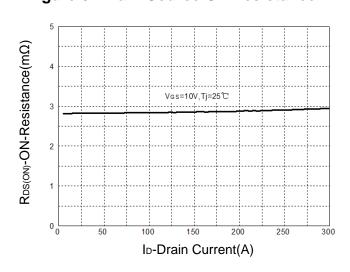


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 9: On-Resistance vs. Temperature

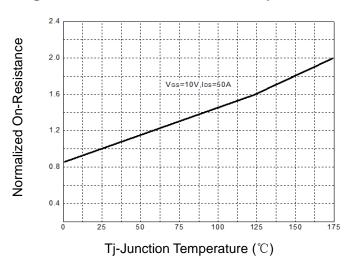


Figure 11: Capacitance Characteristics

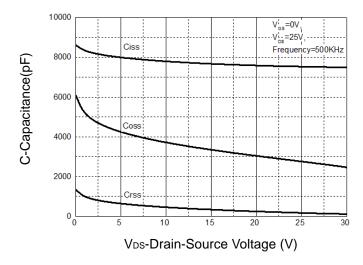


Figure 10: Source-Drain Diode Forward

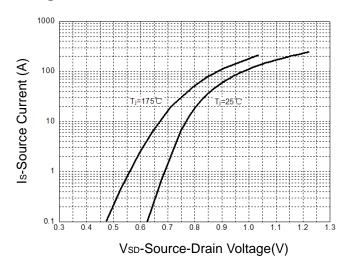
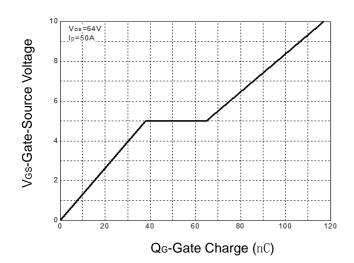
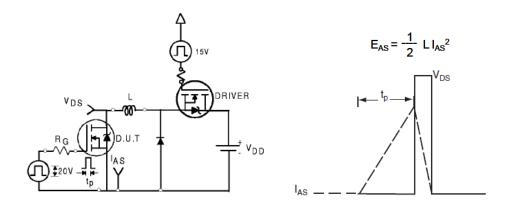


Figure 12: Gate Charge Characteristics

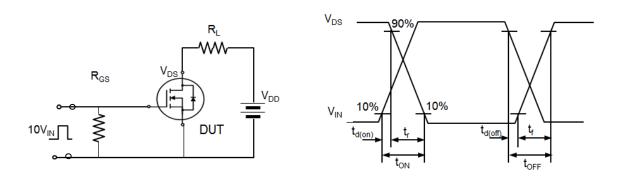




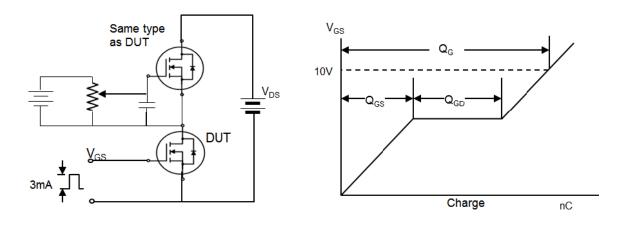
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Gate Charge Test Circuit and Waveforms



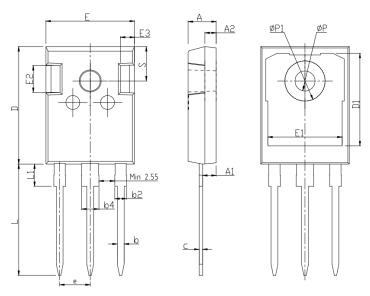


Device Per Unit

Package Type	Unit	Quantity
TO-247A-3L	Tube	30

Package Information

TO-247A-3L

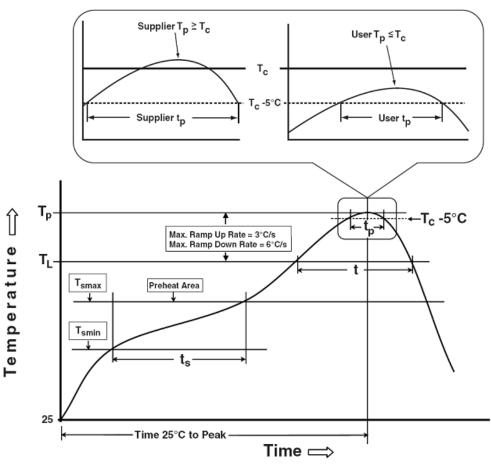


COMMON DIMENSIONS

0)(145.01		mm			
SYMBOL	MIN	NOM	MAX		
А	4.80	5.00	5.20		
A1	2.21	2.41	2.61		
A2	1.85	2.00	2.15		
b	1.11	1.21	1.36		
b2	1.91	2.01	2.21		
b4	2.91	3.01	3.21		
С	0.51	0.61	0.75		
D	20.70	21.00	21.30		
D1	16.25	16.55	16.85		
E	15.50	15.80	16.10		
E1	13.00	13.30	13.60		
E2	4.80	5.00	5.20		
E3	2.30	2.50	2.70		
е		5.44BSC			
L	19.62	19.92	20.22		
L1	-	-	4.30		
ФР	3.40	3.60	3.80		
ФР1	-	-	7.30		
S	6.15BSC				



Classification Profile



Classification Reflow Profiles

Sn-Pb Eutectic Assembly	Pb-Free Assembly	
100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds	
3 °C/second max.	3°C/second max.	
183 °C	217 °C	
60-150 seconds	60-150 seconds	
See Classification Temp in table 1	SeeClassification Tempin table 2	
20** seconds	30** seconds	
6 °C/second max.	6 °C/second max.	
6 minutes max.	8 minutes max.	
	100 °C 150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.	

^{*}Tolerance for peak profile Temperature (T_P) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350	
<2.5 mm	235 °C	220 °C	
≥2.5 mm	220 °C	220 °C	

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500/1000Hrs, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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